

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/743,082	FURUKAWA, SHINJI	
Examiner		Art Unit		Page 1 of 1
Jason T. Whipkey		2622		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,151,421 A	11-2000	Yamada, Tomoko	382/284
*	B	US-2003/0098915 A1	05-2003	Hyodo et al.	348/231.3
*	C	US-6,937,234 B1	08-2005	Long, Timothy Merrick	348/745
*	D	US-2005/0240627 A1	10-2005	Cohen et al.	707/104.1
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10084473 A	03-1998	Japan	IKEGAWA et al.	H04N 001/393
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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